

RoHS

COMPLIANT

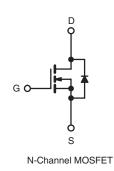
## N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	60					
R <sub>DS(on)</sub> (Ω)	$V_{GS} = 10 V$	0.027				
Q <sub>g</sub> (Max.) (nC)	95					
Q <sub>gs</sub> (nC)	27					
Q <sub>gd</sub> (nC)	46					
Configuration	Single					

### **FEATURES**

- · Isolated Package
- High Voltage Isolation = 2.5 kV<sub>RMS</sub> (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- 175 °C Operating Temperature
- · Dynamic dV/dt Rating
- · Low Thermal Resistance
- Lead (Pb)-free Available





<b>ABSOLUTE MAXIMUM RATINGS</b> T	<sub>C</sub> = 25 °C, u	nless otherw	ise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V <sub>DS</sub>	60	v		
Gate-Source Voltage			V <sub>GS</sub>			± 20
Continuous Drain Current	V <sub>GS</sub> at 10 V	$T_C = 25 \degree C$ $T_C = 100 \degree C$	I <sub>D</sub>	45		
	VGS at 10 V	$T_C = 100 ^{\circ}C$		30	A	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	220		
Linear Derating Factor				0.32	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	100	mJ	
Maximum Power Dissipation	T <sub>C</sub> = 25 °C		P <sub>D</sub> 52		W	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 175	- °C		
Soldering Recommendations (Peak Temperature)	for 10 s			300 <sup>d</sup>		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N · m	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b.  $V_{DD} = 25 \text{ V}$ , starting  $T_J = 25 \text{ °C}$ ,  $L = 129 \text{ }\mu\text{H}$ ,  $R_G = 25 \Omega$ ,  $I_{AS} = 30 \text{ A}$  (see fig. 12). c.  $I_{SD} \leq 52 \text{ A}$ , dI/dt  $\leq 250 \text{ A}/\mu\text{s}$ ,  $V_{DD} \leq V_{DS}$ ,  $T_J \leq 175 \text{ °C}$ .

d. 1.6 mm from case.

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THERMAL RESISTANCE RAT	TINGS							
PARAMETER	SYMBOL	TYP	-	MAX.		UNIT		
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-		65			°C ///	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	- 3.1				°C/W		
<b>SPECIFICATIONS</b> $T_J = 25 \ ^{\circ}C$ ,	unless otherv	vise noted			1	1		1
PARAMETER	SYMBOL	TES	T CONDITI	ONS	MIN.	TYP.	MAX.	UNIT
Static								-
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> =	= 0 V, I <sub>D</sub> = 2	50 μΑ	60	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C,	I <sub>D</sub> = 1 mA	-	0.060	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250 \ \mu A$			1.0	-	3.0	V
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>GS</sub> = ± 20 V			-	-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			-	-	25	μΑ
		V <sub>DS</sub> = 48 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 150 °C			-	-	250	
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub>	= 18 A <sup>b</sup>	-	0.027	-	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> = 25 V, I <sub>D</sub> = 18 A <sup>b</sup>			15	-	-	S
Dynamic					•	•		
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 25 V, f = 1.0 MHz, see fig. 5 f = 1.0 MHz			-	1500	-	
Output Capacitance	C <sub>oss</sub>			-	720	-	pF	
Reverse Transfer Capacitance	C <sub>rss</sub>			-	100	-		
Drain to Sink Capacitance	С			-	12	-		
Total Gate Charge	Qg			= 52 A, V <sub>DS</sub> = 48 V, see fig. 6 and 13 <sup>b</sup>	-	-	95	nC
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V			-	-	27	
Gate-Drain Charge	Q <sub>gd</sub>	see tig		lg. 6 and 135	-	-	46	
Turn-On Delay Time	t <sub>d(on)</sub>				-	19	-	
Rise Time	t <sub>r</sub>	$\label{eq:V_DD} \begin{array}{l} V_{DD} = 30 \; V, \; I_D = 52 \; A, \\ R_G = 9.1 \; \Omega, \; R_D = 0.54 \; \Omega, \\ \text{see fig. } 10^b \end{array}$		-	120	-	ns	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	55	-		
Fall Time	t <sub>f</sub>			-	86	-		
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH	
Internal Source Inductance	L <sub>S</sub>			-	7.5	-		
Drain-Source Body Diode Characteristic	s							
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the		-	-	45	A	
Pulsed Diode Forward Currenta	I <sub>SM</sub>	integral reverse p - n junction diode			-	-		120
Body Diode Voltage	$V_{SD}$	$T_J = 25 \ ^{\circ}C, \ I_S = 30 \ A, \ V_{GS} = 0 \ V^b$			-	-	2.5	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 52 A, dl/dt = 100 A/μs <sup>b</sup>		-	140	300	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$r_{\rm J} = 25$ 0, $r_{\rm F} = 32$ A, $u/ut = 100$ A/ $\mu$ S			-	1.2	2.8	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	ırn-on time i	is negligible (turn	-on is dor	ninated by	L <sub>S</sub> and I	_D)

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.



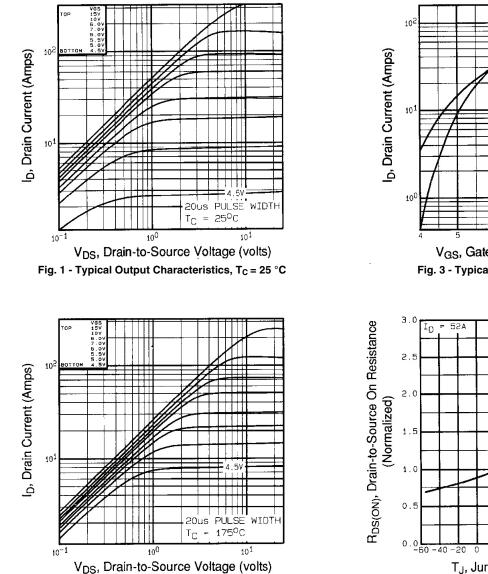
175<sup>0</sup>0

- 25v

20us PULSE WIDTH

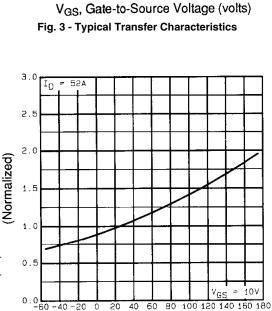
10

VDS



### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

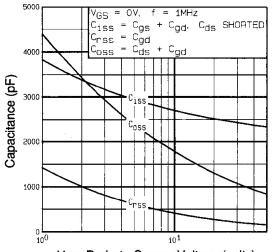
Fig. 2 - Typical Output Characteristics,  $T_c = 175$  °C





### FQPF13N06L





V<sub>DS</sub>, Drain-to-Source Voltage (volts) Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

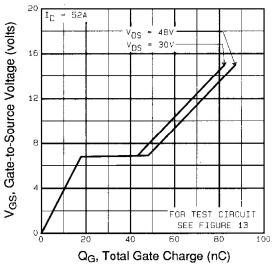


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

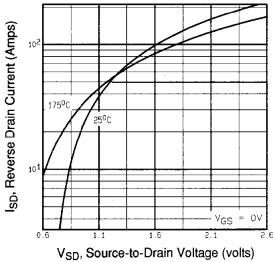
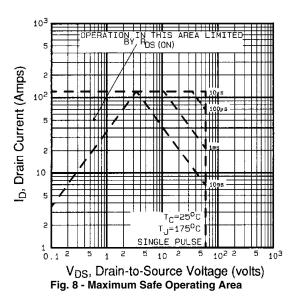


Fig. 7 - Typical Source-Drain Diode Forward Voltage



### FQPF13N06L



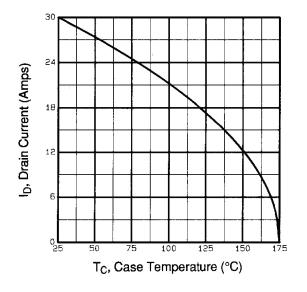


Fig. 9 - Maximum Drain Current vs. Case Temperature

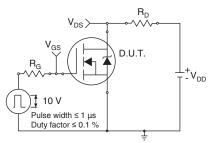


Fig. 10a - Switching Time Test Circuit

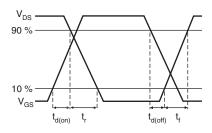


Fig. 10b - Switching Time Waveforms

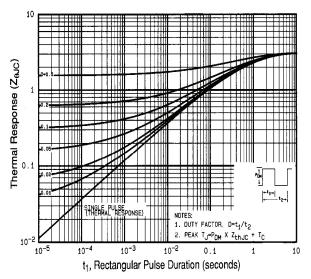
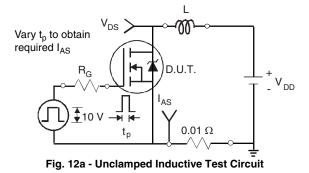


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



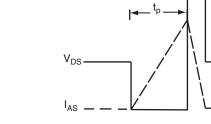
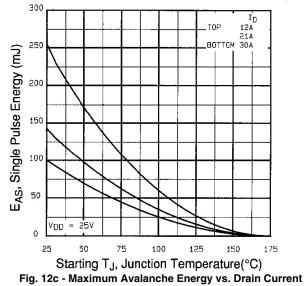


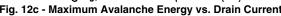
Fig. 12b - Unclamped Inductive Waveforms

DS

 $\mathsf{V}_{\mathsf{D}\mathsf{D}}$ 







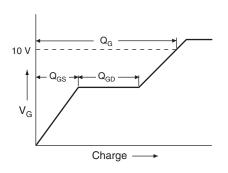
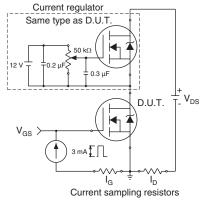
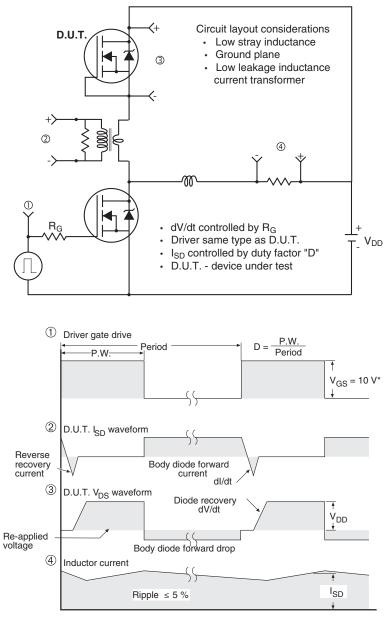


Fig. 13a - Basic Gate Charge Waveform









Peak Diode Recovery dV/dt Test Circuit

\*  $V_{GS} = 5$  V for logic level devices

Fig. 14 - For N-Channel



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